

## **Search Notes**



**Application/Control No.**

10/635 649

Examiner

VAN T. PHAM

**Applicant(s)/Patent under  
Reexamination**

HATAKE ET AL

Art Unit

2627

**SEARCHED**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**